OKNETIC

TAILORED SOLUTIONS FOR GAN-ON-SI APPLICATIONS

SILICON WAFERS ENABLING SMOOTH GAN-ON-SI EPITAXY

SILICON WAFERS DESIGNED FOR GAN-ON-SI

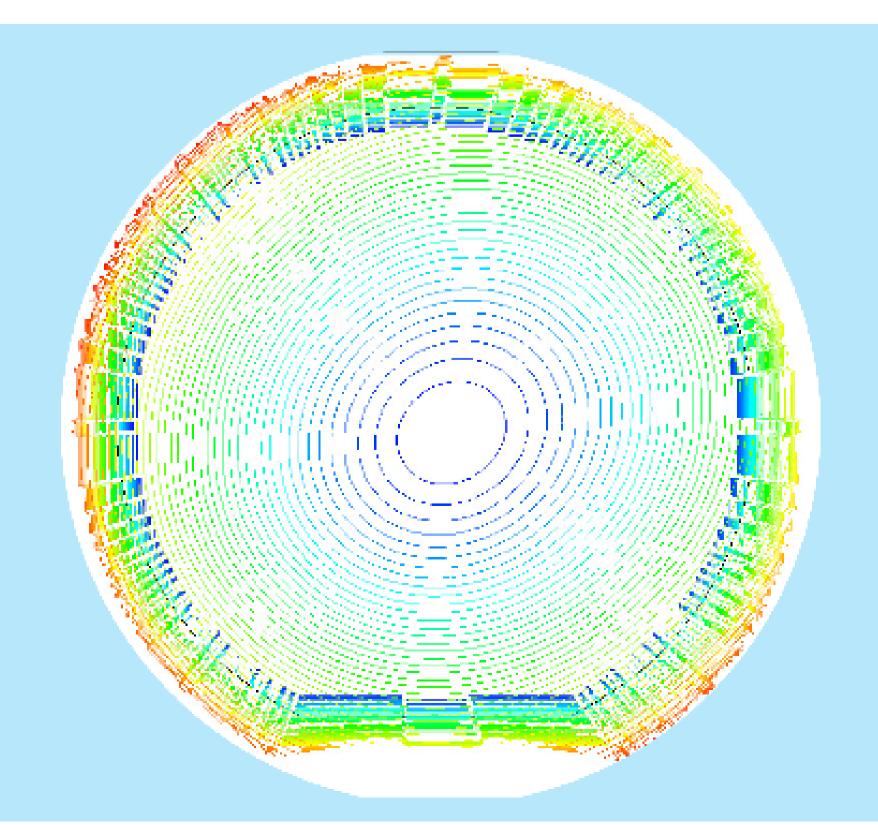
WIDE SELECTION OF WAFER PARAMETERS TO

APPLICATION NEEDS (POWER & RF)

- Silicon wafers that are designed to facilitate the growing of high-quality gallium nitride and to offset the extreme stresses of the GaN epi process.
- Okmetic technology was developed in close co-operation with several industrial players utilizing all the widely used GaN production processes.
- Customized wafers simplify the epitaxial process setup, tuning and ramping-up to production.
- Full wafer shape analysis is available as part of the wafer tailoring.

MATCH YOUR APPLICATION NEEDS

- Custom wafer thickness options to reduce wafer bow and warpage (150-200mm up to 1,150µm).
- LTO option for the back surface for further stress management.
- Option for up to ≥ 7,000 Ohm-cm resistivity with suitable Oi control, balancing between resistivity stability and lattice integrity.
- Option for high resistivity on-orientation <111> with tight orientation control.
- Also SOI wafers can be used as GaN-on-Si substrates for instance in building new HEMT devices (High-Electron-Mobility Transistor).



SUPERIOR PERFORMANCE

Okmetic GaN-on-Si optimized wafers have consistently shown superior performance in GaN-on-Si epitaxy. During the GaN epi process, wafer curvature is monitored and con-

trolled. Okmetic wafer bow returns close to the initial stage after GaN stack deposition process. This is illustrated on the left in the gematrical mapping of Okmetic Si substrate processed into a GaN-on-Si wafer at Aalto University.

